

<b>Notice of References Cited</b>	Application/Control No. 10/825,454	Applicant(s)/Patent Under Reexamination CHAPPERT ET AL.	
	Examiner Martin J Angebrannt	Art Unit 1756	Page 1 of 2

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,383,598	05-2002	Fullerton et al.	428/65.7
	C	US-6,331,364	12-2001	Baglin et al.	428/694T
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	J	US-			
	K	US-			
	L	US-			
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	W	Le Boite' M.G., et al., Study of ion beam mixed multilayers via neutron scattering"., Mater. Lett., Vol. 6(5,6) pp. 173-176 (03/1988)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	K	US-			
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